

SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS

PRODUCT SPECIFICATION 規格書

CUSTOMER: DATE:

(客戶): 志盛翔 (日期):2018-05-08

CATEGORY (品名) : ALUMINUM ELECTROLYTIC CAPACITORS

DESCRIPTION (型号) : GT $50V1200\mu F(\phi 16x20)$

VERSION (版本) : 01

Customer P/N :

SUPPLIER :

SUPPLI	IER
PREPARED (拟定)	CHECKED (审核)
孟庆庆	付婷婷

CUS	TOMER
APPROVAL (批准)	SIGNATURE (签名)

ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

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Rev.	Date	Mark	Page	Contents	Purpose	Drafter	Approver

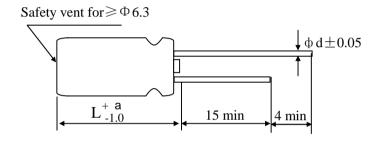
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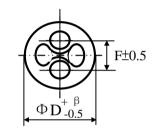
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Table 1 Product Dimensions and Characteristics

Unit: mm





а	L<20 : a=1.5; L≥20 : a=2.0
β	$\Phi D < 20 : \beta = 0.5; \Phi D \ge 20 : \beta = 1.0$

N o.	SAMXON Part No.	WV (Vdc)	Cap. (μF)	Cap. tolerance	Temp. range($^{\circ}\mathbb{C}$)	tan δ (120Hz, 20℃)	Leakage Current (μA,2min)	Max Ripple Current at 105℃ 100kHz (mA rms)	Impedance at 20°C 100kHz (Ωmax)	Load lifetime (Hrs)		ension (mm) F	фd	Sleev
1	EGT128M1HK20RR**P	50	1200	-20%~+20%	-40~105	0.10	600	2210	0.034	10000	16X20	7.5	0.8	PET

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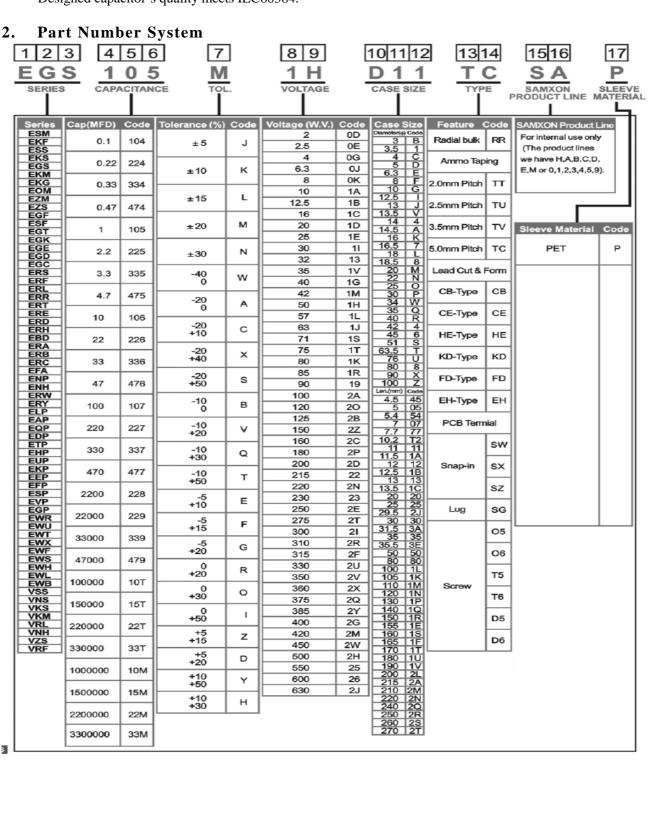
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1. Application

This specification applies to polar Aluminum electrolytic capacitor (foil type) used in electronic equipment. Designed capacitor's quality meets IEC60384.

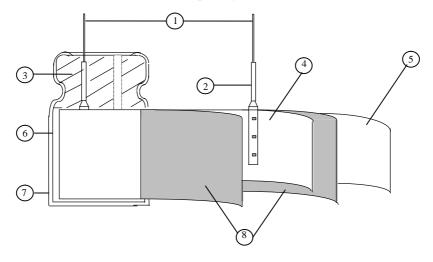


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3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	PET
8	Separator	Electrolyte paper

4. Characteristics

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature :15°C to 35°C
Relative humidity : 45% to 85%
Air Pressure : 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature $: 20^{\circ}\text{C} \pm 2^{\circ}\text{C}$ Relative humidity : 60% to 70%Air Pressure : 86kPa to 106kPa

Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

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	ITEM				PERFO	RMANC	CE			
	Rated voltage									
	(WV)	WV (V.DC)	6.3	10	16	25	35	50	63	100
4.1		SV (V.DC)	8	13	20	32	44	63	79	125
	Surge voltage (SV)									
4.2	Nominal capacitance (Tolerance)	<condition> Measuring F Measuring V Measuring T <criteria> Shall be with</criteria></condition>	requency oltage emperat	: N ure : 20)±2℃	than 0.5V				
4.3	Leakage current	Condition> Connecting t minutes, and Criteria> Refer to Table	he capad then, me		_		istor (1	k Ω ± 10)Ω) in s	eries for
4.4	tan δ	<condition> See 4.2, Norn <criteria> Refer to Table</criteria></condition>	n Capac	itance, fo	or measui	ring frequ	iency, vo	oltage and	d tempera	ature.
4.5	Terminal strength	0.5r	ength of apacitor rength of apacitor, 2~3 second rength of leading and leading	f Termina applied f applied f ands, and d wire	force to als. Force to be then ber	ent the te	rminal (1	1~4 mm toriginal property Bending	from the	rubber) f
		<criteri< td=""><td></td><td>0.8mm</td><td>ı</td><td>0 (1.0)</td><td>reakage (</td><td></td><td>ness at the</td><td>e termina</td></criteri<>		0.8mm	ı	0 (1.0)	reakage (ness at the	e termina

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		<condition></condition>								
		STEP	Testin	g Tempe	rature(°C)			Time		
		1		20±2	2	Time	to reach	thermal e	equilibriu	ım
		2		-40(-25)	±3	Time	to reach	thermal e	equilibrii	ım
		3		20 ± 2			to reach		_	
		4		105±			to reach		_	
		5		$\frac{103 \pm 20 \pm 2}{20 \pm 2}$			to reach		-	
		<criteria></criteria>		20 1 2		Tillic	to reach	uncilliai (.quiiioiii	1111
		a. $\tan \delta$ shall be	withi	n the lim	it of Item	1 1The 1	akaga cu	irrent me	acurad c	hall not
		more than 8 time				4.4111C K	akage et	iiiciii iiic	asurcu s	nan not
	Temperature	b. In step 5, tan		-		it of Iter	n 4 4The	leakage	current	shall no
	characteristi	more than the spe			iiii tiic iiii	nt of ite	11 4.41110	Teakage	current	siiaii iio
4.6	cs	c. At-40°C (-25°			(z) ratio s	hall not	exceed th	e value o	of the fol	lowing
		table.	0), 11	прешинее	(L) Tatio	ilaii ilot	onecea un	e varae (or the 101	10 111119
		Working Voltage	(V)	6.3	10	16	25	35	50	63
		Z-25°C/Z+20°C		4	3	2	2	2	2	2
		Z-40°C/Z+20°C		8	6	4	3	3	3	3
		Z-40 C/Z120 C		- 0					<u> </u>	
		Working Voltage	(V)	100						
		Z-25°C/Z+20°C	\mathcal{C}	2						
		Z-40°C/Z+20°C	\mathcal{C}	3						
		For capacitance v	1 .	1000		_	.1 1000		7.05/7	2000
		Tor capacitance v	vaiue :	> 1000 µ	F, Add 0.3	o per ano	ther 1000) µ F for	Z-25/Z+	20 C,
		Tor capacitance v	value 2	> 1000 µ		-				
		-			Add 1.0	per ano	ther 1000	μFfor		
		Capacitance, tan 8			Add 1.0	per ano	ther 1000	μFfor		
		Capacitance, tan δ	3, and	l impedan	Add 1.0	per anor	ther 1000 red at 120	μF for 2 Hz.	Z-40°C/Z	Z+20℃.
		Capacitance, tan & Condition> According to IEC	$\frac{3}{5}$, and $\frac{3}{5}$	l impedan	Add 1.0 nce shall b	per anote measures, The ca	ther 1000 red at 120 apacitor is	μ F for 2 OHz.	Z-40°C/Z	Z+20°C.
		Capacitance, tan & < Condition > According to IEC 105°C ±2 with I	5, and C6038 OC bia	l impedan 4-4No.4.	Add 1.0 nce shall b	per anote measures, The carated ripp	ther 1000 red at 120 apacitor is	μ F for 2	Z-40°C/Z at a tempe ble 1 . (Tl	Z+20°C. erature cone sum cone
		Capacitance, tan 8 <condition> According to IEC 105°C ±2 with I DC and ripple p</condition>	5, and C6038 OC bia	d impedant 4-4No.4. as voltage	Add 1.0 nce shall b	per anote measures, The cated ripp	ther 1000 red at 120 apacitor is le current e rated w	Hz. S stored at for Tabyorking	Z-40°C/Z	Z+20°C. erature one sum of then the
	Load	Capacitance, tan 8 <condition> According to IEC 105°C ±2 with I DC and ripple p product should be</condition>	5, and C6038 OC biaseak veak veeteste	d-4No.4 as voltage shod after 16	Add 1.0 ance shall be a plus the reall not explusive the reall not explusive the real of t	per anote measures, The cated ripp	ther 1000 red at 120 apacitor is le current e rated w	Hz. S stored at for Tabyorking	Z-40°C/Z	Z+20°C. erature one sum of then the
4.7	Load life	Capacitance, tan 8 <condition> According to IEC 105°C ±2 with I DC and ripple p</condition>	5, and C6038 OC biaseak veak veeteste	d-4No.4 as voltage shod after 16	Add 1.0 ance shall be a plus the reall not explusive the reall not explusive the real of t	per anote measures, The cated ripp	ther 1000 red at 120 apacitor is le current e rated w	Hz. S stored at for Tabyorking	Z-40°C/Z	Z+20°C. erature one sum of then the
4.7	Load life test	Capacitance, tan 8 <condition> According to IEC 105°C ±2 with D DC and ripple p product should be result should mee</condition>	C6038 C6038 C bia beak ve teste	4-4No.4. as voltage of after 16 following	Add 1.0 nce shall be 13 method eplus the reall not ex 6 hours recognized table:	b per anote measures, The cated ripp acced the covering	ther 1000 red at 120 apacitor is le current e rated w time at at	Hz. S stored at for Tabyorking	Z-40°C/Z	Z+20°C. erature one sum of then the
4.7	life	Capacitance, tan 8 <condition> According to IEC 105°C ±2 with IDC and ripple p product should be result should mee <criteria></criteria></condition>	C6038 OC biaseak ve teste the state the	4-4No.4 as voltage soltage shad after 16 following	Add 1.0 nce shall be 13 method eplus the reall not ex 6 hours recognized table:	b per anote measures, The cated ripp acced the covering	ther 1000 red at 120 red at 120 red at 120 red at 120 red at 20 red with a table red at 20 red a	P F for D DHz. S stored a t for Tab yorking γ mospher	Z-40°C/Z	Z+20°C. erature one sum of then the
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4.7	life	Capacitance, tan & Condition> According to IEC 105°C ±2 with IDC and ripple p product should be result should mee Criteria> The characteristic Leakage c	5, and C6038 DC bia beak ve teste et the state shall current	4-4No.4 as voltage shad after 16 following	Add 1.0 ance shall be 13 method e plus the reall not ex 6 hours recognized table: e followin Value in	b per anote measures, The cated ripp acced the covering grequire 4.3 shall 25% of	apacitor is le current e rated whime at at ments. be satisfi initial va	P F for D DHz. s stored a t for Tab yorking w mospher fied	z-40°C/z at a tempo ble 1 . (The voltage) ic condit	Z+20°C. erature one sum of then the
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		<criteria></criteria>	
		The characteristic shall meet t	
	G1 16	Leakage current	Value in 4.3 shall be satisfied
4.0	Shelf	Capacitance Change	Within $\pm 25\%$ of initial value.
4.8	life	tan δ	Not more than 200% of the specified value.
	test	Appearance	There shall be no leakage of electrolyte.
		increase. Please apply voltage	stored more than 1 year, the leakage current may e through about 1 k Ω resistor, if necessary.
	Suga		e 15~35℃.
4.9	Surge	Leakage current	Not more than the specified value.
	test	Capacitance Change	Within $\pm 15\%$ of initial value.
		tan δ	Not more than the specified value.
		Appearance	There shall be no leakage of electrolyte.
		Attention:	There shall be no leakage of electrolyte.
			ge at abnormal situation only. It is not applicable to sucl
4.10	Vibration test	perpendicular directions. Vibration frequency ra Peak to peak amplitude Sweep rate Mounting method: The capacitor with diameter g in place with a bracket. 4mm or less	: 1.5mm : 10Hz ~ 55Hz ~ 10Hz in about 1 minute greater than 12.5mm or longer than 25mm must be fixed Within 30°
		Inner construction	tems shall be tested: No intermittent contacts, open or short circuiting. No damage of tab terminals or electrodes. No mechanical damage in terminal. No leakage
			of electrolyte or swelling of the case.

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Resistance to solder heat test	Condition> The capacitor shall be test soldering temperature Dipping depth Dipping speed Dipping time Criteria>	or shall tor3 +1 see be left unsurement	: 245±3°C : 2mm : 25±2.5mm/ : 3±0.5s A minimum immersed be immersed into econds to 1.5~2.0n under the normal to ent. Not more than the Within ±10% of the conds to 1.5% of the	o solder beamm from emperature	of the surface beath at 260±5 the body of capre and normal	°C for 10 =
Resistance to solder heat	Soldering temperature Dipping depth Dipping speed Dipping time <criteria> Coating quality <condition> Terminals of the capacitot 1seconds or 400 ± 10°C for 1~2 hours before means <criteria> Leakage current Capacitance Change tan δ</criteria></condition></criteria>	or shall tor3 +1 see be left unsurement	: 245±3°C : 2mm : 25±2.5mm/ : 3±0.5s A minimum immersed be immersed into econds to 1.5~2.0n under the normal to ent. Not more than the Within ±10% of the conds to 1.5% of the	o solder beamm from emperature	of the surface beath at 260±5 the body of capre and normal	°C for 10 =
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solder heat	Leakage current Capacitance Change $\tan \delta$		Within ±10% o		ed value.	
	Capacitance Change tan δ	,	Within ±10% o		ed value.	
	tan δ	;		f initial v		
			Not more than th		value.	
	Appearance		1 tot more man u	Not more than the specified value.		
			There shall be no	o leakage	of electrolyte.	
	G 11/1				-	
	<condition> Temperature Cycle:Acco</condition>	rding to	o IEC60384 4No.	1.7matha	de appositor el	all ba
					us, capacitoi si	ian be
	placed in an oven, the condition according as be Temperature				ime	
	(1)+20°C			≤3	Minutes	
					Minutes	
Change of	(2)Rated low temperature (-40°C) (-25°C) (3)Rated high temperature (+105°C)					
temperature test	(3)Rated high temperature (+105°C) 30 ± 2 Minutes (1) to (3)=1 cycle, total 5 cycle					
test	(1) to (3)=1 cycle, to Criteria>	nai 5 Cy	ycie			
		neet the	following require	ement		
					value	
	**					
	_	4No.4.1	12 methods, capac	itor shall	be exposed for	r 500+8
				,		8
	<criteria></criteria>					
Damp heat	Leakage current	Not n	more than the spec	ified valu	ie.	
test	Capacitance Change	Withi	$\sin\pm20\%$ of initia	al value.		
	tan δ	Not n	more than 120% or	f the spec	rified value.	
	Appearance	There	e shall be no leaka	ige of elec	ctrolyte.	
	Damp heat test	$\begin{tabular}{ c c c c c } \hline Leakage current \\ \hline tan δ \\ \hline Appearance \\ \hline & & & & \\ \hline & & & & \\ \hline & & & & \\ \hline & & & &$			$\begin{array}{ c c c c c }\hline tan & & Not more than the specified value & Appearance & There shall be no leakage of order & Condition > \\ & & & & & & & & & & & & & & & & & &$	

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4.15	Vent test	Condition> The following test only apply to those products with vent products at diameter ³ Æ6.3 with vent. D.C. test The capacitor is connected with its polarity reversed to a DC power source. Then a current selected from below table is applied. Table 3> Diameter (mm) DC Current (A) 22.4 or less 1 Over 22.4 10 *Criteria> The vent shall operate with no dangerous conditions such as flames or dispersion of pieces of the capacitor and/or case.
	Maximum permissible	Condition> The maximum permissible ripple current is the maximum A.C current at 120Hz and can be applied at maximum operating temperature Table-1 The combined value of D.C voltage and the peak A.C voltage shall not exceed the rated voltage and shall not reverse voltage. Frequency Multipliers: Coefficient Freq. (Hz) 50 120 300 1k 100k
4.16	(ripple current)	Cap. (μ F) 0.45 0.55 0.70 0.90 1.00 39~330 0.60 0.70 0.85 0.95 1.00 390~1000 0.65 0.75 0.90 0.98 1.00 1200~3900 0.75 0.80 0.95 1.00 1.00

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5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

	Substances					
	Cadmium and cadmium compounds					
Heavy metals	Lead and lead compounds					
Heavy metals	Mercury and mercury compounds					
	Hexavalent chromium compounds					
	Polychlorinated biphenyls (PCB)					
Chloinated	Polychlorinated naphthalenes (PCN)					
organic	Polychlorinated terphenyls (PCT)					
compounds	Short-chain chlorinated paraffins(SCCP)					
	Other chlorinated organic compounds					
D : 1	Polybrominated biphenyls (PBB)					
Brominated	Polybrominated diphenylethers(PBDE) (including					
organic	decabromodiphenyl ether[DecaBDE])					
compounds	Other brominated organic compounds					
Tributyltin compo	ounds(TBT)					
Triphenyltin com	pounds(TPT)					
Asbestos						
Specific azo com	pounds					
Formaldehyde						
Beryllium oxide						
Beryllium coppe	Beryllium copper					
Specific phthalate	es (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)					
Hydrofluorocarbo	on (HFC), Perfluorocarbon (PFC)					
Perfluorooctane s	ulfonates (PFOS)					
Specific Benzotri	azole					

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Attachment: Application Guidelines

1. Circuit Design

1.1 Operating Temperature and Frequency

Electrolytic capacitor electrical parameters are normally specified at 20°C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.

- 1) Effects of operating temperature on electrical parameters
 - a) At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
 - b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
- (2) Effects of frequency on electrical parameters
 - a) At higher frequencies capacitance and impedance decrease while $tan\delta$ increases.
 - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).

1.2 Operating Temperature and Life Expectancy

See the file: Life calculation of aluminum electrolytic capacitor

1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

(1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

(2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

(3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

(4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

1.4 Using Two or More Capacitors in Series or Parallel

(1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

(2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

1.5 Capacitor Mounting Considerations

(1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

(2) Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

(3)Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

(4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

 $\phi 6.3 \text{-}\phi 16\text{mm:}2\text{mm minimum, } \phi 18 \text{-}\phi 35\text{mm:}3\text{mm minimum, } \phi 40\text{mm or greater:}5\text{mm minimum.}$

(5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

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(6) Wiring Near the Pressure Relief Vent

Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100° C may be released which could dissolve the wire insulation and ignite.

(7) Circuit Board patterns Under the Capacitor

Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short.

(8) Screw Terminal Capacitor Mounting

Do not orient the capacitor with the screw terminal side of the capacitor facing downwards.

Tighten the terminal and mounting bracket screws within the torque range specified in the specification.

1.6 Electrical Isolation of the Capacitor

Completely isolate the capacitor as follows.

- (1) Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths
- (2) Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths.
- 1.7 The Product endurance should take the sample as the standard.
- 1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling.

1.9 Capacitor Sleeve

The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor.

The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures.

CAUTION!

Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use.

- (1) Provide protection circuits and protection devices to allow safe failure modes.
- (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure.

2. Capacitor Handling Techniques

- 2.1 Considerations Before Using
- (1) Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment.
- (2) Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about $1k\Omega$.
- (3) Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately $1k\Omega$.
- (4) If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors.
- (5) Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result.

2.2 Capacitor Insertion

- (1) Verify the correct capacitance and rated voltage of the capacitor.
- (2) Verify the correct polarity of the capacitor before inserting.
- (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals.
- (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor.

For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection.

2.3 Manual Soldering

- (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less.
- (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal.
- (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads.
- (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve.

2.4 Flow Soldering

- (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result.
- (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.
- (3) Do not allow other parts or components to touch the capacitor during soldering.

2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

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2.6 Capacitor Handling after Solder

- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.

2.7 Circuit Board Cleaning

- (1) Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60 °C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

Alkali solvents : could attack and dissolve the aluminum case.

Petroleum based solvents: deterioration of the rubber seal could result.

Xylene : deterioration of the rubber seal could result.

Acetone : removal of the ink markings on the vinyl sleeve could result.

- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.

2.8 Mounting Adhesives and Coating Agents

When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

3. Precautions for using capacitors

3.1 Environmental Conditions

Capacitors should not be stored or used in the following environments.

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100 $^\circ\! C$ temperatures.

If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.

If electrolyte or gas is ingested by month, gargle with water.

If electrolyte contacts the skin, wash with soap and water.

5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a 1000Ω , current limiting resistor for a time period of 30 minutes . If the expired date of products date code is over eighteen months, the products should be return to confirmation.

5.1 Environmental Conditions

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The capacitor shall be not use in the following condition:

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.

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